


<b>Search Notes</b> 	<b>Application/Control No.</b> 10667492	<b>Applicant(s)/Patent Under Reexamination</b> BESSIOS ET AL.
	<b>Examiner</b> LEILA MALEK	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	242,259,286	6/30/2009	L.M.
341	58,59,95	6/30/2009	L.M.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, IEEE, Inventor Name Search, Consulted M. Ghayour and D. Swerdlow	6/30/2009	L.M.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	242,259	6/30/2009	L.M.
341	58,59,95	6/30/2009	L.M.

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